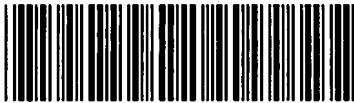


**Search Notes**

Application/Control No.

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Examiner

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Applicant(s)/Patent under  
Reexamination

UMENO, KEN

Art Unit

2193

**SEARCHED**

Class	Subclass	Date	Examiner
708	250-256	4/18/2007	MAI

**INTERFERENCE SEARCHED**

Class	Subclass	Date	Examiner

**SEARCH NOTES  
(INCLUDING SEARCH STRATEGY)**

	DATE	EXMR
Inventor(s) search Double Patent Check Data Bases Search (see search history printout(s))	4/18/2007	MAI